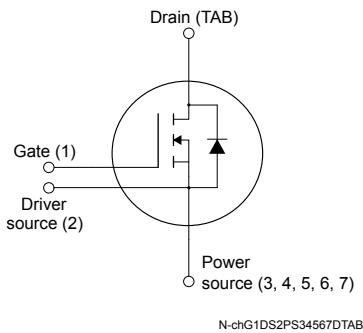
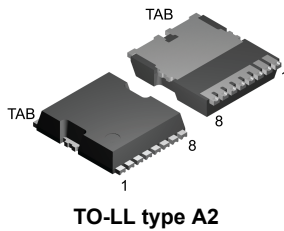


## N-channel 600 V, 39 mΩ typ., 57 A, MDmesh M9 Power MOSFET in a TO-LL package



### Product status link

[STO60N045M9](#)

### Product summary

<b>Order code</b>	STO60N045M9
<b>Marking</b>	60N045M9
<b>Package</b>	TO-LL type A2
<b>Packing</b>	Tape and reel

### Features

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>
STO60N045M9	600 V	45 mΩ	57 A

- Very low FOM (R<sub>DS(on)</sub> · Q<sub>g</sub>)
- Higher dv/dt capability
- Excellent switching performance
- Easy to drive
- 100% avalanche tested
- Excellent switching performance thanks to the extra driving source pin

### Application

- AC-DC converters
- DC-DC converters
- Microinverter

### Description

This N-channel Power MOSFET is based on the most innovative super-junction MDmesh M9 technology, suitable for medium/high voltage MOSFETs featuring very low R<sub>DS(on)</sub> per area. The silicon based M9 technology benefits from a multi-drain manufacturing process which allows an enhanced device structure. The resulting product has one of the lower on-resistance and reduced gate charge values, among all silicon based fast switching super-junction Power MOSFETs, making it particularly suitable for applications that require superior power density and outstanding efficiency.

# 1 Electrical ratings

**Table 1. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{GS}$	Gate-source voltage	$\pm 30$	V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$	57	A
	Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$	36	
$I_{DM}^{(2)}$	Drain current (pulsed)	220	A
$P_{TOT}$	Total power dissipation at $T_C = 25\text{ }^\circ\text{C}$	245	W
$dv/dt^3$	Peak diode recovery voltage slope	50	V/ns
$di/dt^3$	Peak diode recovery current slope	900	A/ $\mu\text{s}$
$dv/dt^{(4)}$	MOSFET $dv/dt$ ruggedness	120	V/ns
$T_{stg}$	Storage temperature range	-55 to 150	$^\circ\text{C}$
$T_J$	Operating junction temperature range		$^\circ\text{C}$

1. Referred to TO-247 long leads package.
2. Pulse width limited by safe operating area.
3.  $I_{SD} \leq 29\text{ A}$ ,  $V_{DS} (\text{peak}) < V_{(BR)DSS}$ ,  $V_{DD} = 400\text{ V}$ .
4.  $V_{DS} (\text{peak}) < V_{(BR)DSS}$ ,  $V_{DD} = 400\text{ V}$ .

**Table 2. Thermal data**

Symbol	Parameter	Value	Unit
$R_{thJC}$	Thermal resistance, junction-to-case	0.51	$^\circ\text{C/W}$
$R_{thJA}$	Thermal resistance, junction-to-ambient <sup>(1)</sup>	43	$^\circ\text{C/W}$
	Thermal resistance, junction-to-ambient <sup>(2)</sup>	22	

1. When mounted on a standard 1 inch<sup>2</sup> area of FR-4 PCB with 2-oz copper.
2. When mounted on 40x40 mm area of FR-4 PCB with 2-oz copper.

**Table 3. Avalanche characteristics**

Symbol	Parameter	Value	Unit
$I_{AR}$	Avalanche current, repetitive or not repetitive (pulse width limited by $T_J$ max.)	7	A
$E_{AS}$	Single pulse avalanche energy (starting $T_J = 25\text{ }^\circ\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50\text{ V}$ )	720	mJ

## 2 Electrical characteristics

$T_C = 25\text{ °C}$  unless otherwise specified.

**Table 4. On/off-states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0\text{ V}$ , $I_D = 1\text{ mA}$	600			V
$I_{DSS}$	Zero gate voltage drain current	$V_{GS} = 0\text{ V}$ , $V_{DS} = 600\text{ V}$			1	$\mu\text{A}$
		$V_{GS} = 0\text{ V}$ , $V_{DS} = 600\text{ V}$ , $T_C = 125\text{ °C}$ <sup>(1)</sup>			200	
$I_{GSS}$	Gate-body leakage current	$V_{DS} = 0\text{ V}$ , $V_{GS} = \pm 25\text{ V}$			$\pm 100$	nA
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250\text{ }\mu\text{A}$	3.2	3.7	4.2	V
$R_{DS(on)}$	Static drain-source on-resistance	$V_{GS} = 10\text{ V}$ , $I_D = 29\text{ A}$		39	45	m $\Omega$

1. Specified by design, not tested in production.

**Table 5. Dynamic characteristics**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 400\text{ V}$ , $f = 250\text{ kHz}$ , $V_{GS} = 0\text{ V}$	-	4600	-	pF
$C_{oss}$	Output capacitance		-	83	-	pF
$C_{oss\ eq.}^{(1)}$	Equivalent output capacitance	$V_{DS} = 0\text{ to }400\text{ V}$ , $V_{GS} = 0\text{ V}$	-	1230	-	pF
$R_g$	Intrinsic gate resistance	$f = 250\text{ kHz}$ , open drain	-	0.8	-	$\Omega$
$Q_g$	Total gate charge	$V_{DD} = 400\text{ V}$ , $I_D = 29\text{ A}$ , $V_{GS} = 0\text{ to }10\text{ V}$ (see Figure 14. Test circuit for gate charge behavior)	-	110	-	nC
$Q_{gs}$	Gate-source charge		-	30	-	nC
$Q_{gd}$	Gate-drain charge		-	38	-	nC

1.  $C_{oss\ eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to stated value.

**Table 6. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 300\text{ V}$ , $I_D = 29\text{ A}$ , $R_G = 4.7\text{ }\Omega$ , $V_{GS} = 10\text{ V}$ (see Figure 13. Switching times test circuit for resistive load and Figure 18. Switching time waveform)	-	26	-	ns
$t_r$	Rise time		-	6	-	ns
$t_{d(off)}$	Turn-off delay time		-	80	-	ns
$t_f$	Fall time		-	3.5	-	ns

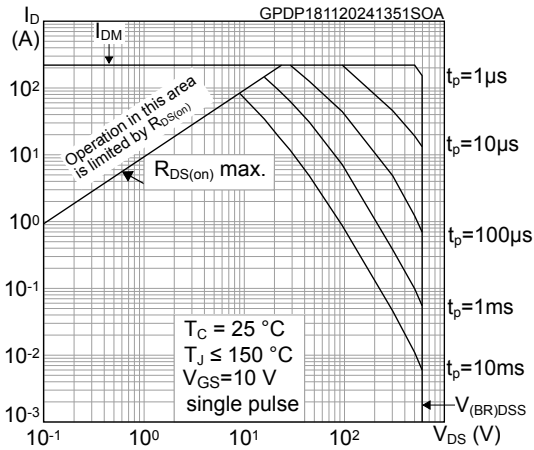
**Table 7. Source-drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}^{(1)}$	Source-drain current		-		57	A
$I_{SDM}^{(2)}$	Source-drain current (pulsed)		-		220	A
$V_{SD}^{(3)}$	Forward on voltage	$V_{GS} = 0\text{ V}$ , $I_{SD} = 57\text{ A}$	-		1.6	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 57\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ , $V_{DD} = 60\text{ V}$ (see Figure 15. Test circuit for inductive load switching and diode recovery times)	-	250		ns
$Q_{rr}$	Reverse recovery charge		-	3		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	24		A
$t_{rr}$	Reverse recovery time	$I_{SD} = 57\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ , $V_{DD} = 60\text{ V}$ , $T_J = 150\text{ }^\circ\text{C}$ (see Figure 15. Test circuit for inductive load switching and diode recovery times)	-	390		ns
$Q_{rr}$	Reverse recovery charge		-	7.5		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	33		A

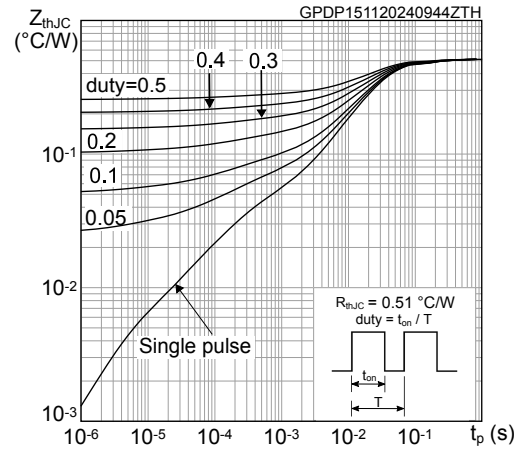
1. Referred to TO-247 long leads package.
2. Pulse width is limited by safe operating area.
3. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%.

## 2.1 Electrical characteristics (curves)

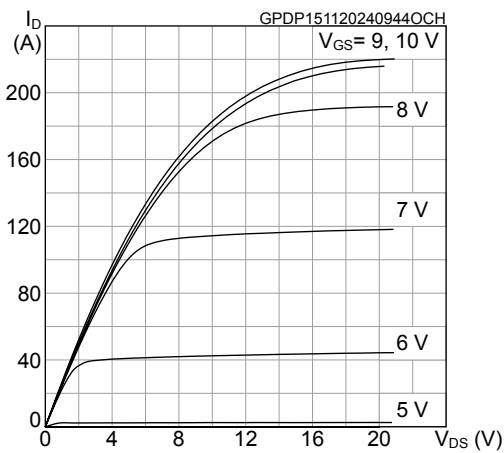
**Figure 1. Safe operating area**



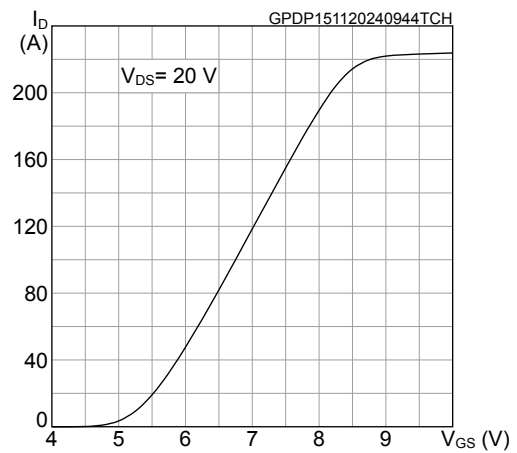
**Figure 2. Maximum transient thermal impedance**



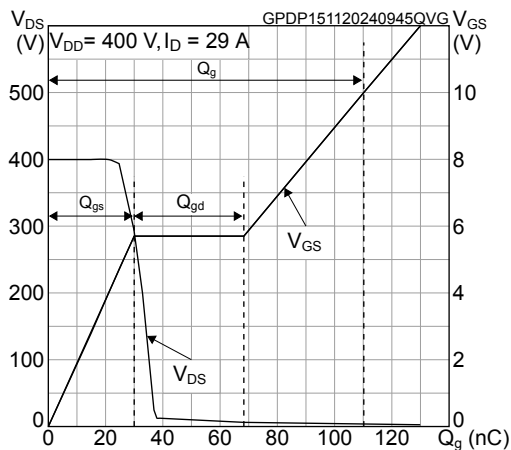
**Figure 3. Typical output characteristics**



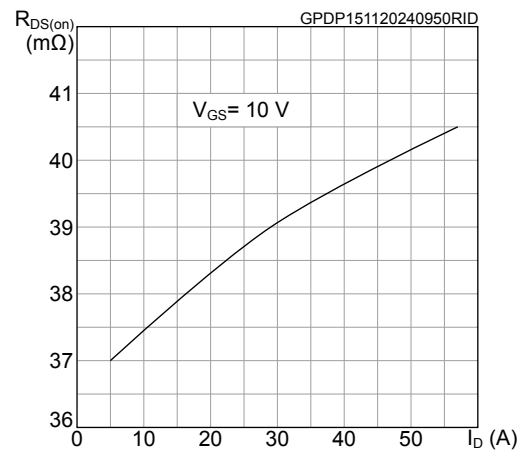
**Figure 4. Typical transfer characteristics**



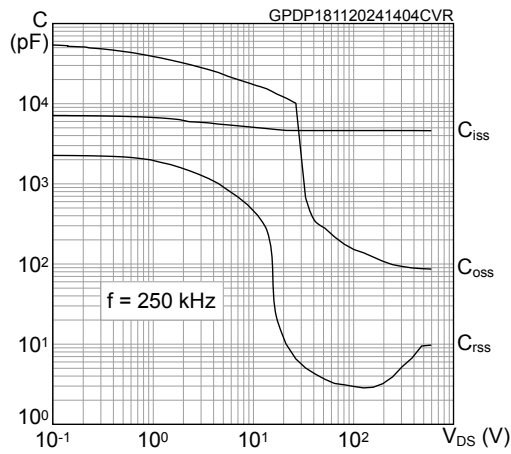
**Figure 5. Typical gate charge characteristics**



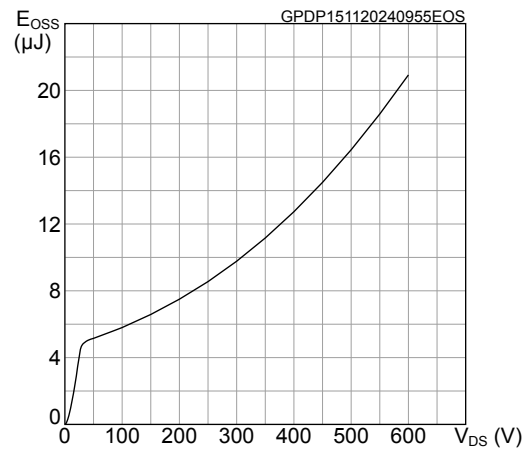
**Figure 6. Typical drain-source on-resistance**



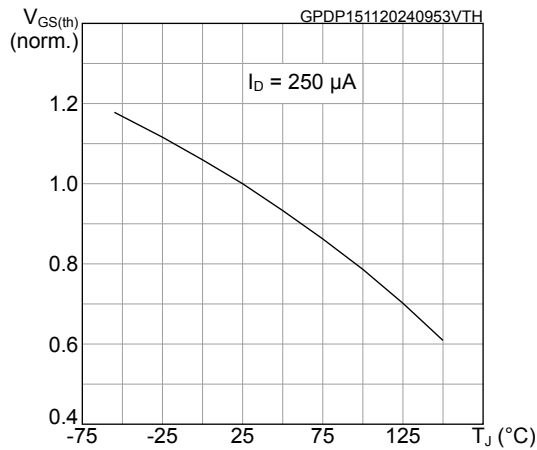
**Figure 7. Typical capacitance characteristics**



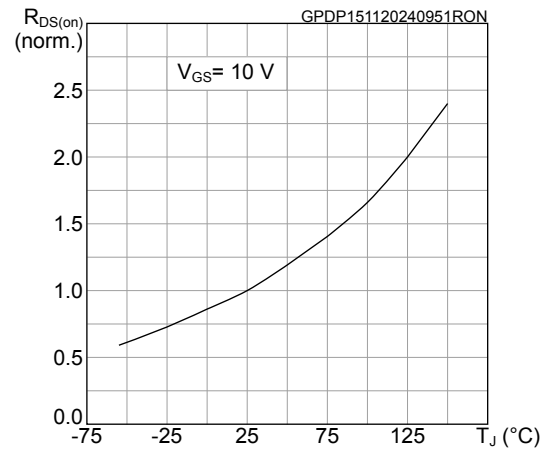
**Figure 8. Typical output capacitance stored energy**



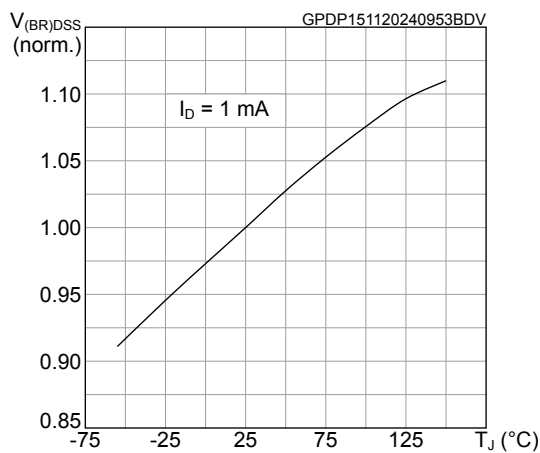
**Figure 9. Normalized gate threshold vs temperature**



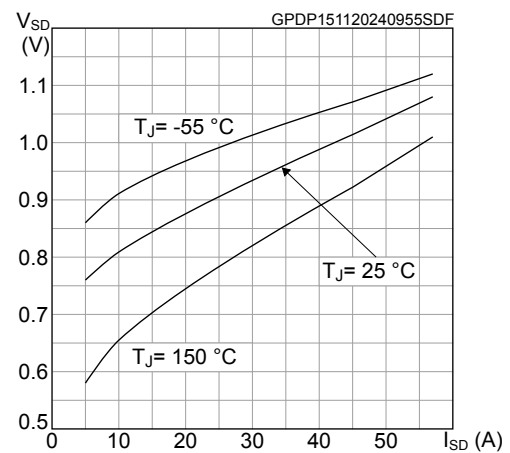
**Figure 10. Normalized on-resistance vs temperature**



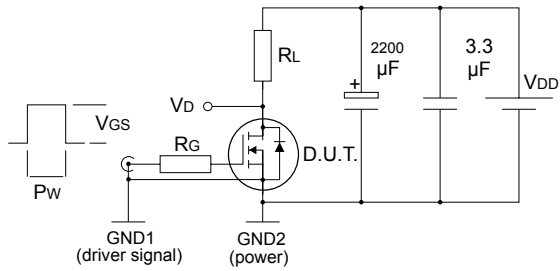
**Figure 11. Normalized breakdown voltage vs temperature**



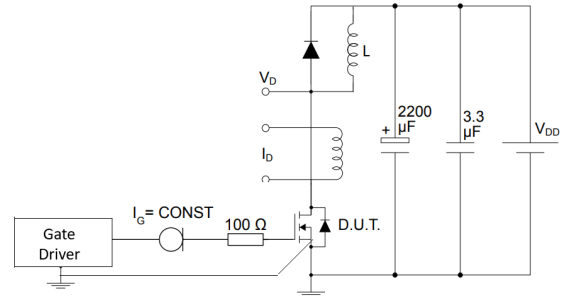
**Figure 12. Typical reverse diode forward characteristics**



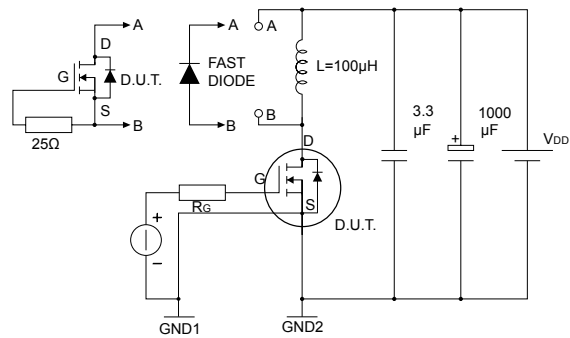
### 3 Test circuits

**Figure 13. Switching times test circuit for resistive load**


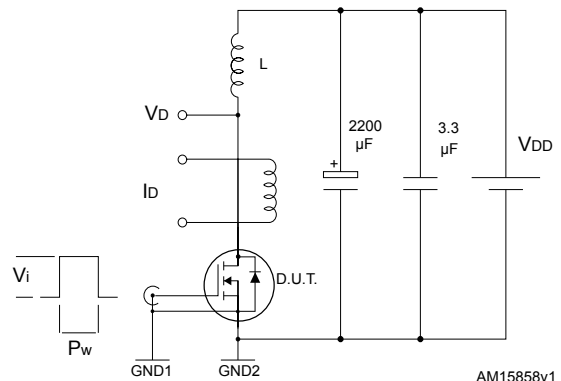
AM15855v1

**Figure 14. Test circuit for gate charge behavior**


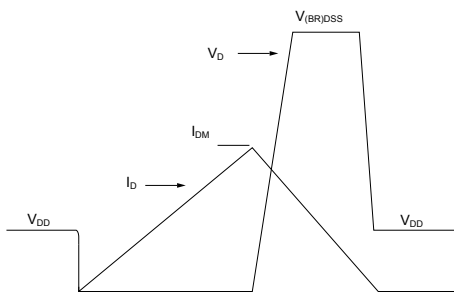
GPD191120241113SA

**Figure 15. Test circuit for inductive load switching and diode recovery times**


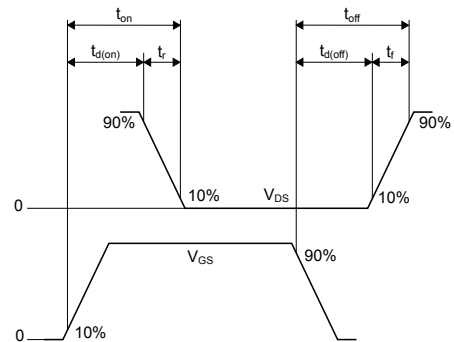
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**Figure 16. Unclamped inductive load test circuit**


AM15858v1

**Figure 17. Unclamped inductive waveform**


AM01472v1

**Figure 18. Switching time waveform**


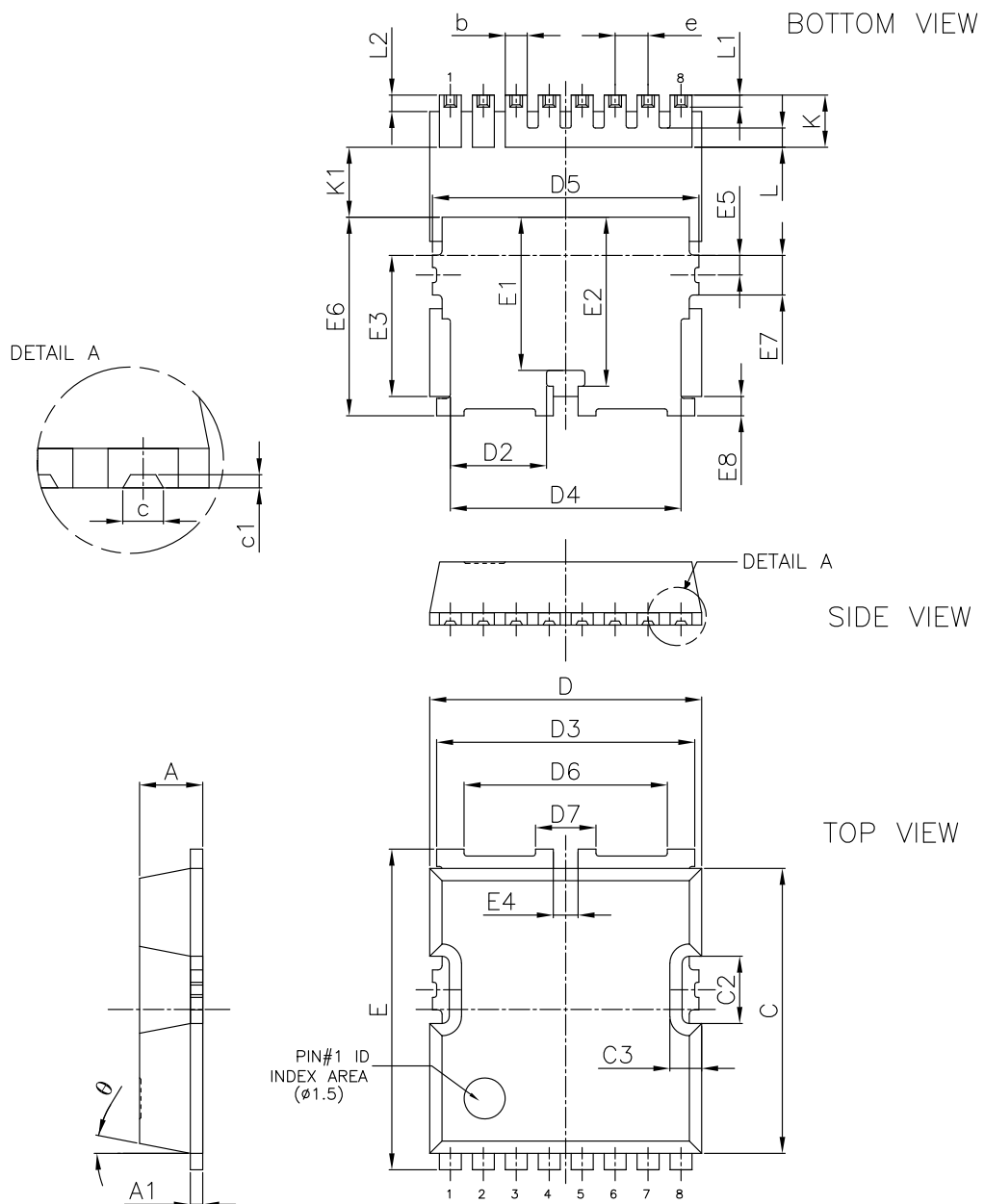
AM01473v1

## 4 Package information

To meet environmental requirements, ST offers these devices in different grades of **ECOPACK** packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions, and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

### 4.1 TO-LL type A2 package information

Figure 19. TO-LL type A2 package outline



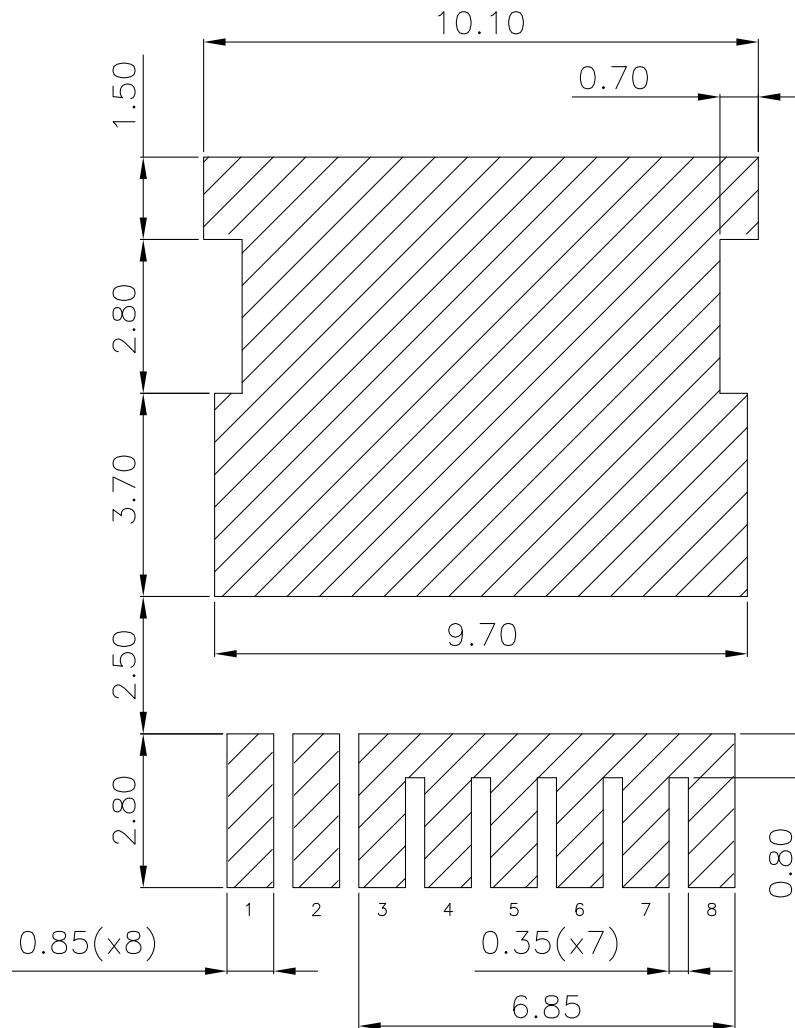
DM00276569\_7\_type\_A2



**Table 8. TO-LL type A2 package mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	2.20	2.30	2.40
A1	0.40	0.48	0.60
b	0.70	0.80	0.90
c		0.46	
c1		0.15	
C	10.28	10.38	10.48
C2	2.35	2.45	2.55
C3		1.16	
D	9.80	9.90	10.00
D2	3.30	3.50	3.70
D3	9.30	9.40	9.50
D4	8.20	8.40	8.60
D5	9.50	9.70	9.90
D6		7.40	
D7		2.20	
e		1.20	
E	11.48	11.68	11.88
E1		5.58	
E2		6.15	
E3		5.14	
E4		0.90	
E5		0.72	
E6	7.03	7.23	7.43
E7		1.44	
E8	0.50	0.70	0.90
K	1.70	1.90	2.10
K1	2.40		
L		0.70	
L1		0.44	
L2	0.40	0.60	0.80
θ		11°	

Figure 20. TO-LL type A2 recommended footprint (dimensions are in mm)



DM00276569\_7\_type\_A2

## 4.2 TO-LL packing information

Figure 21. Carrier tape outline and dimensions

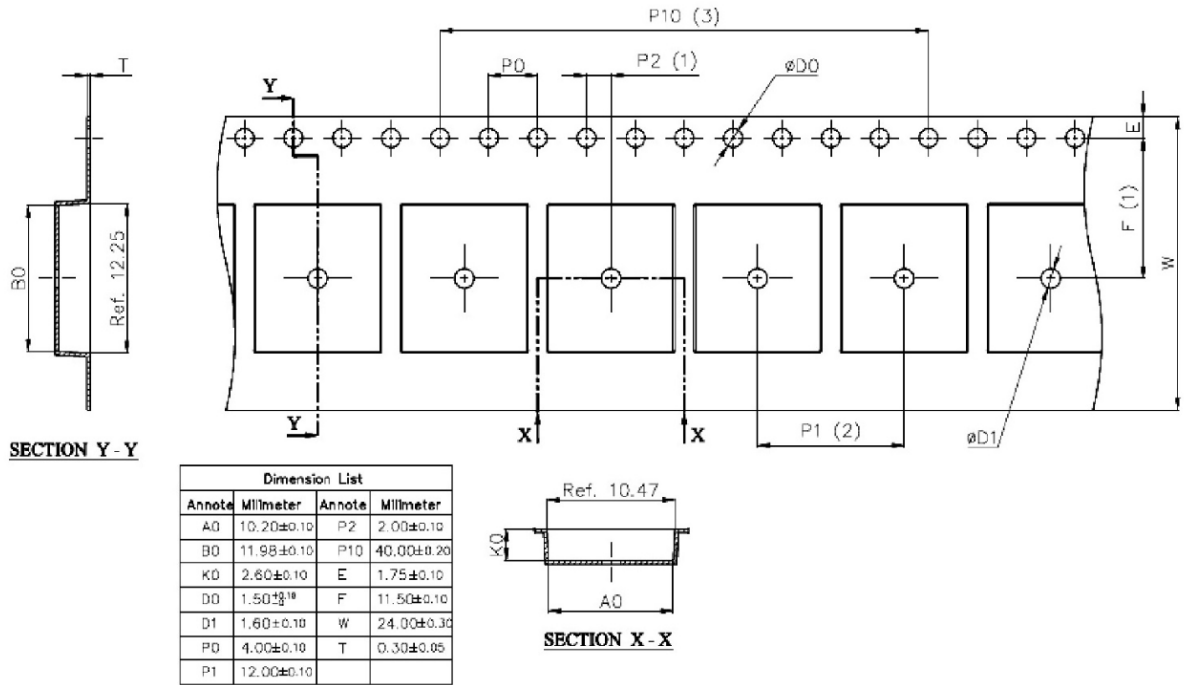
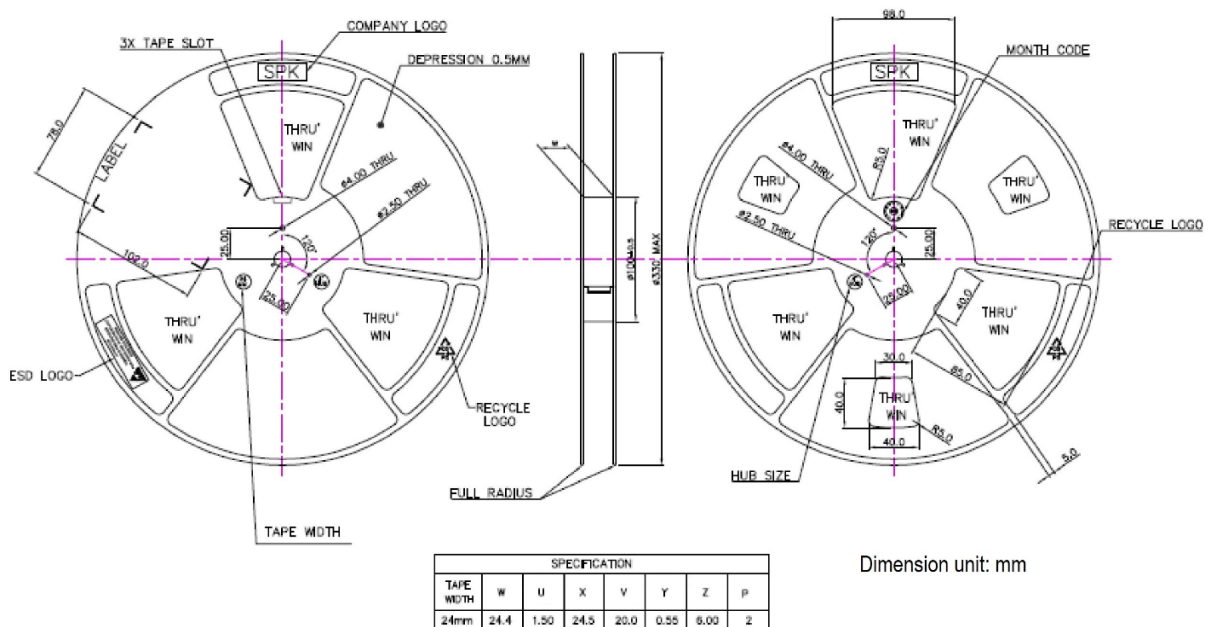
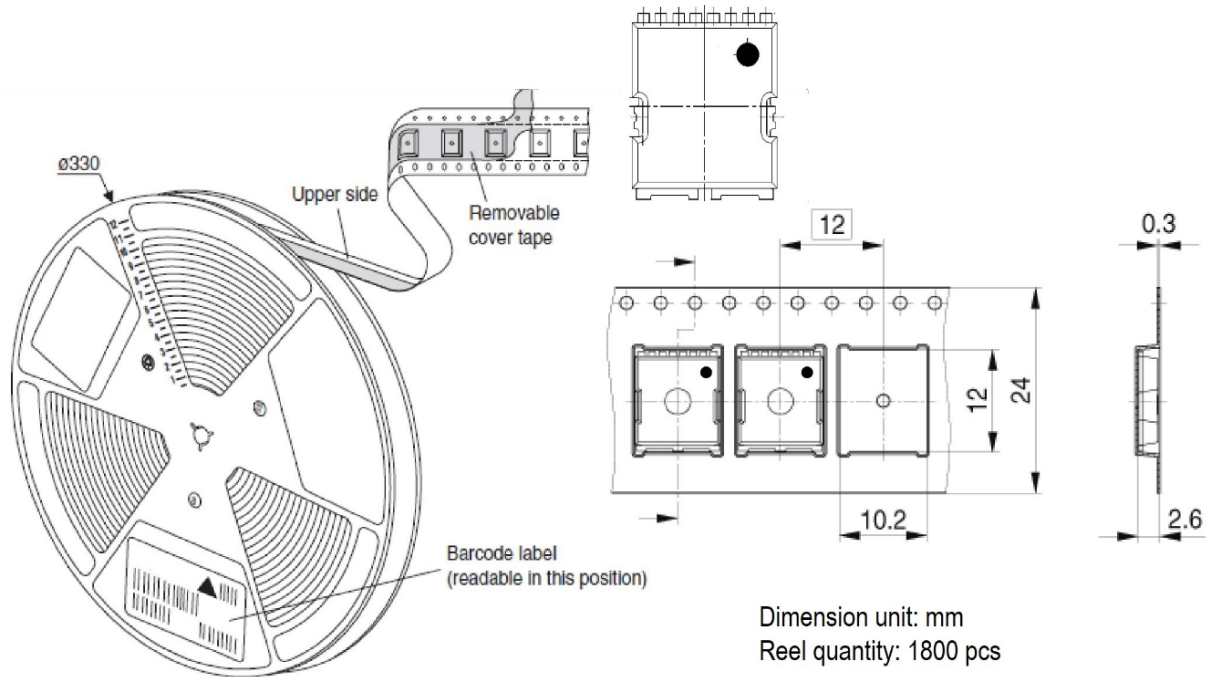


Figure 22. Reel outline and dimensions



**Figure 23. TO-LL orientation in tape pocket**



## Revision history

**Table 9. Document revision history**

Date	Revision	Changes
27-Nov-2024	1	First release.
13-Jan-2025	2	Updated <a href="#">Table 5</a> . Dynamic characteristics.

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## Contents

<b>1</b>	<b>Electrical ratings</b> .....	<b>2</b>
<b>2</b>	<b>Electrical characteristics</b> .....	<b>3</b>
<b>2.1</b>	<b>Electrical characteristics (curves)</b> .....	<b>5</b>
<b>3</b>	<b>Test circuits</b> .....	<b>7</b>
<b>4</b>	<b>Package information</b> .....	<b>8</b>
<b>4.1</b>	<b>TO-LL type A2 package information</b> .....	<b>8</b>
<b>4.2</b>	<b>TO-LL packing information</b> .....	<b>11</b>
	<b>Revision history</b> .....	<b>13</b>

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